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BF	E	AA	5,882,749	3/16/99	Jones et al.		1-	<del> </del>	LI ro.	PROPRINT
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BF	PE	AF	3,454,210	7/8/69	Spiegel et al.		_			
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			OTHER R	EFERENCES (In	ncluding Author, Title	, Date, Pertinent Pages, Etc.)				<u> </u>
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in conformance and not considered. Include copy of this form with next communication to applicant.